

<b>Notice of References Cited</b>	Application/Control No. 10/573,194		Applicant(s)/Patent Under Reexamination MALEK ET AL.	
	Examiner Michael Maskell		Art Unit 2881	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,019,706 A	05-1991	Allemann et al.	250/291
*	B	US-6,784,421 B2	08-2004	Park, Melvin A.	250/281
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Vartanian, et al ("High Performance Fourier Transform Ion Cyclotron Resonance Mass Spectrometry Via a Single Trap Electrode" J. Am. Soc. Mass Spectrom, Elsevier Science Inc. (U.S.) Vol. 6 (No. 9) p. 812-821, Sept 1, 1995)
	V	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.